

Vishay Siliconix

N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)	
	0.027 at V _{GS} = 4.5 V	8		
20	0.032 at V _{GS} = 2.5 V	8	8.3 nC	
	0.040 at V _{GS} = 1.8 V	8		

FEATURES

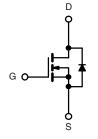
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



RoHS

APPLICATIONS

- DC/DC Converter
- · Load Switches



N-Channel MOSFET

		SO-8		
s	1		8	D
s	2		7	D
S	3		6	D
G	4		5	D
	1	Top Viou		

Ordering Information: Si4196DY-T1-E3 (Lead (Pb)-free)

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	20	V		
Gate-Source Voltage	V _{GS}	± 8	¬		
	T _C = 25 °C		8 ^e		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		8 ^e		
Continuous Diain Current (1 _J = 150 °C)	T _A = 25 °C	I _D	6.4 ^{b, c}		
	T _A = 70 °C		5.1 ^{b, c}		
Pulsed Drain Current		I _{DM}	20	A	
Continuous Courses Busin Binds Coursest	T _C = 25 °C	_	3.8		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.6 ^{b, c}		
Single Pulse Avalanche Current	1 0411	I _{AS}	5		
Avalanche Energy L = 0.1 mH		E _{AS}	1.25	mJ	
	T _C = 25 °C		4.6		
Maximum Power Dissipation	T _C = 70 °C	D.	2.9	w	
	T _A = 25 °C	P _D	2.0 ^{b, c}	VV	
	T _A = 70 °C		1.28 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b,d}	t ≤ 10 s	R _{thJA}	52	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	22	27	- C/VV	

Notes

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 110 $^{\circ}\text{C/W}.$
- e. Package limited.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static		1			l	1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		21		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 3.0			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	0.4		1.0	٧	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	- μΑ	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	10			Α	
		$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.021	0.027	+	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 5 \text{ A}$		0.025	0.032	Ω	
	, ,	V _{GS} = 1.8 V, I _D = 2.5 A		0.031	0.040	1	
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 8 A		28		S	
Dynamic ^b		-			l		
Input Capacitance	C _{iss}			830			
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		115		pF	
Reverse Transfer Capacitance	C _{rss}	30 . 40		63			
Teresto Transfer Suparitance		$V_{DS} = 10 \text{ V}, V_{GS} = 8 \text{ V}, I_{D} = 8 \text{ A}$		14.5	22		
Total Gate Charge	Q_g	103 10 1, 103 0 1, 10 0 1 1		8.3	12.5	nC	
Gate-Source Charge	Q _{gs}	V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 8 A		1.1	1 1 1 1		
Gate-Drain Charge	Q _{gd}	20 7 do 7 b		1.1			
Gate Resistance	R _g	f = 1 MHz	0.6	3.0	6.0	Ω	
Turn-On Delay Time	t _{d(on)}			8	16		
Rise Time	t _r	$V_{DD} = 10 \text{ V, R}_{1} = 2 \Omega$		13	25	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		33	60		
Fall Time	t _f	Ç ,		9	18		
Turn-On Delay Time	t _{d(on)}			5	10		
Rise Time	t _r	$V_{DD} = 10 \text{ V, R}_{1} = 2 \Omega$		12	24		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 8 \text{ V}, R_q = 1 \Omega$		22	40		
Fall Time	t _f	, and the second		8	16		
Drain-Source Body Diode Characteristic	cs ·				l		
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			3.8		
Pulse Diode Forward Current ^a	I _{SM}				20	Α	
Body Diode Voltage	V _{SD}	I _S = 5.4 A		0.78	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	-		11	22	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			4	8	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		6			
Reverse Recovery Rise Time	t _b		5		ns		

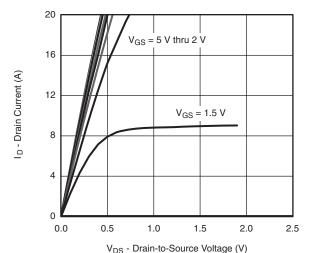
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

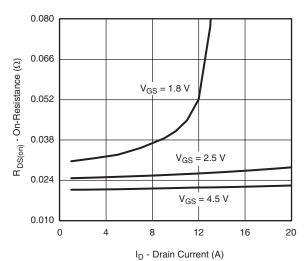


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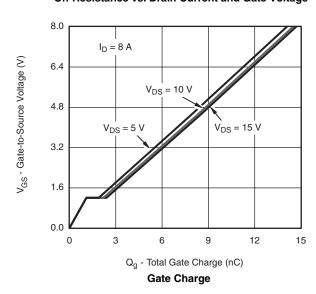
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

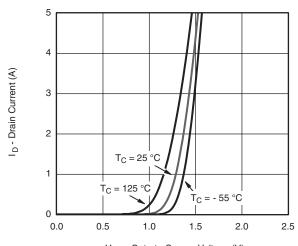


Output Characteristics

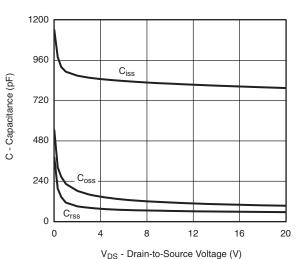


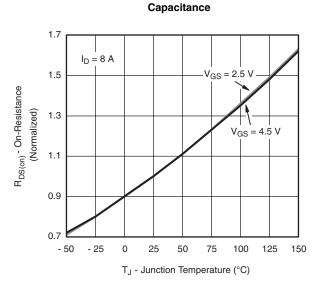
On-Resistance vs. Drain Current and Gate Voltage





V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**





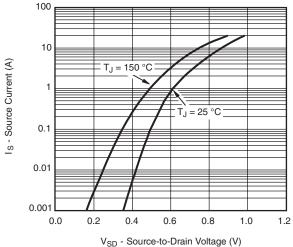
On-Resistance vs. Junction Temperature

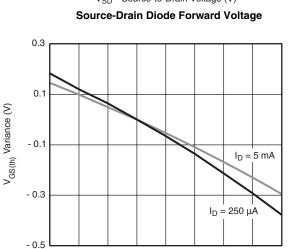
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





T_J - Temperature (°C) Threshold Voltage

50

75

100

125

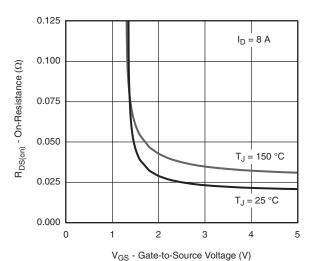
150

- 25

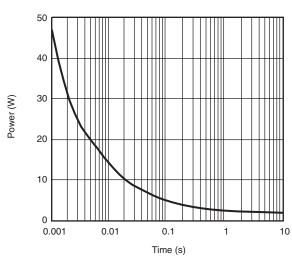
- 50

0

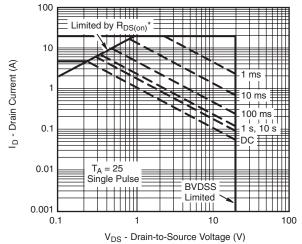
25



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



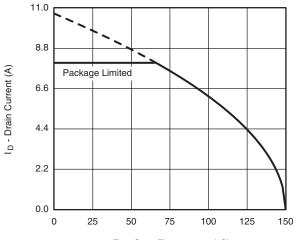
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient



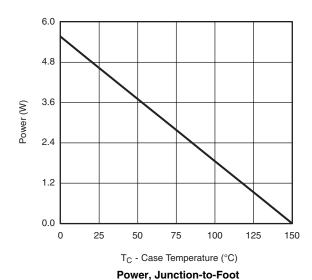
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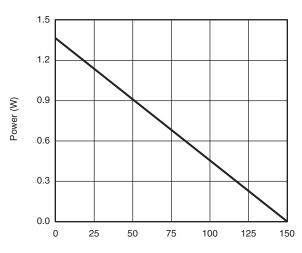
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





T_A - Ambient Temperature (°C)

Power, Junction-to-Ambient

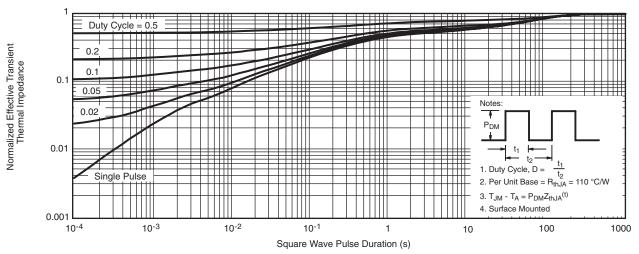
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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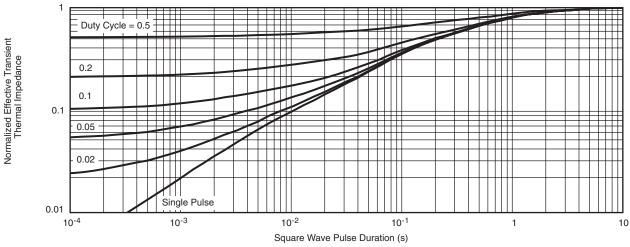
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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